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Quantum Oscillations from Nontrivial States in Quasi-Two-Dimensional Dirac Semimetal ZrTe₅ Nanowires

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Recently discovered Dirac semimetal ZrTe₅ bulk crystal, exhibits nontrivial conducting states in each individual layer, holding great potential for novel spintronic applications. Here, to reveal the transport properties of ZrTe₅, we fabricated ZrTe₅ nanowires (NWs) devices, with much larger surface-to-volume ratio than bulk materials. Quantum oscillations induced by the two-dimensional (2D) nontrivial conducting states have been observed from these NWs and a finite Berry phase of $\sim\pi$ is obtained by the analysis of Landau-level fan diagram. More importantly, the absence of the Aharonov-Bohm (A-B) oscillations, along with the SdH oscillations, suggests that the electrons only conduct inside each layer. And the intralayer conducting is suppressed because of the weak connection between adjacent layers. Our results demonstrate that ZrTe₅ NWs can serve as a suitable quasi-2D Dirac semimetal with high mobility ($\sim 85000\text{ cm}^2\text{V}^{-1}\text{s}^{-1}$) and large nontrivial conductance contribution (up to 8.68%).

The simple binary compound ZrTe₅ is known as a thermoelectric material with layered structure. Recently it has been theoretically predicted as a 2D TI with a bulk bandgap of 0.4 eV¹ in the single layer form, while its three-dimensional (3D) version has been reported with many contradictory results such as 3D TI^{2,3}, 3D strong TI⁴ and quasi-2D or 3D Dirac semimetal⁵⁻⁹. Our previous study has suggested that the transport property of bulk ZrTe₅ is a collective behavior of many individual monolayers¹⁰. However, the critical transport phenomena in NWs which have a much larger surface-to-volume ratio comparing to their bulk forms have not been fully studied.

Here, we have fabricated ZrTe₅ NWs devices to probe the electric transport from the nontrivial conducting states. We report the Shubnikov-de Hass (SdH) oscillations originated from the nontrivial states of each monolayer. The SdH interactions reveal a well-defined 2D Fermi surface lasting up to 20 K. The finite Berry phase of $\sim\pi$ with a high mobility of $85000\text{ cm}^2\text{V}^{-1}\text{s}^{-1}$ clarifies the topological nontrivial nature. More importantly, the A-B oscillations were not observed when the magnetic field was applied along the current direction parallel to the NW. All of these suggest that the electrons only conduct within each layer and cannot hop between different layers, since the interlayer coupling between adjacent layers is too weak. According to the calculation by H. Weng *et al.*, the binding energy of ZrTe₅ is only 12.5 meV, much lower than Bi₂Se₃ (27.6 meV) and very close to graphite (9.3 meV)¹.

Results

Morphology and structural characterization of ZrTe₅ NWs. Figure 1a exhibits the scanning electron microscope (SEM) image of a ZrTe₅ NW with a diameter of $\sim 290\text{ nm}$. The length of our ZrTe₅ NWs ranges from a few microns to tens of microns. Figure 1b is the tilted SEM of the NW with a tilt angle of 30°. It shows clearly the layer steps on the side walls.

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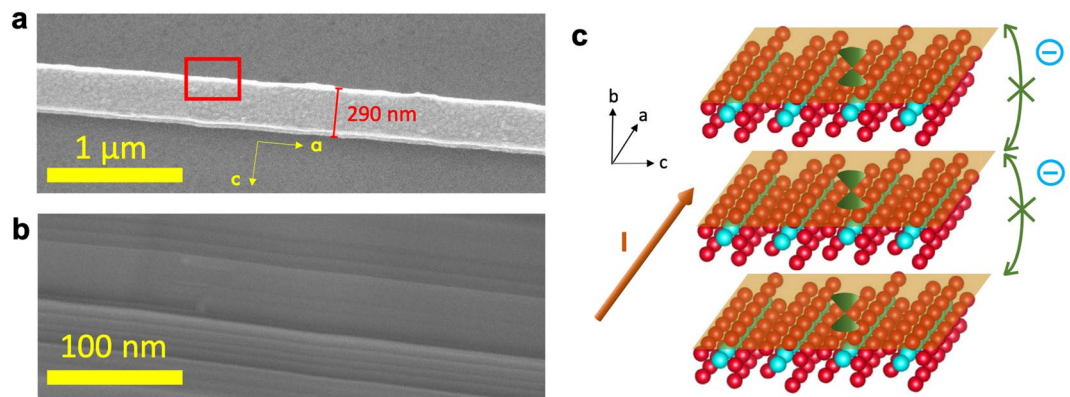


Figure 1. Morphology characterization of ZrTe₅ NWs. **(a)** SEM image of a ZrTe₅ NW, with a diameter of ~290 nm. **(b)** A 30° tilt SEM zoom-in image of the rectangular frame in **a**. It clearly shows steps on the side (ab plane). **(c)** A schematic diagram of nontrivial conducting states existing on each layer of ZrTe₅. The yellow sheets represent the conducting states.

The crystallographic structure of ZrTe₅ is an orthorhombic layered structure¹¹ which is shown in Fig. 2a. Prism chains of ZrTe₃ (Te^p) is along the a-axis, and these prismatic chains are bonded via zigzag Te atoms (Te^z) along the c-axis to form a 2D sheet of ZrTe₅ in the a-c plane. The sheets of ZrTe₅ form a layered structure stacking along the b-axis. The primitive unit cell contains two formula units with two prismatic chains and two zigzag chains, as indicated by the dashed black square in Fig. 2a.

To perform the transmission electron microscopy (TEM)-energy dispersive X-ray spectrometry (EDX) analyses, the ZrTe₅ crystal NWs were dispersed in ethanol and deposited onto a carbon film supported by a 200 mesh, 3 mm diameter copper grid. Figure 2b reveals the atomic level details of the a-c plane of ZrTe₅. From the TEM image, we are able to determine the lattice constants of a and c are 0.4 nm and 1.4 nm, respectively. At the same time, from the X-ray diffraction (XRD) pattern (Fig. 2c), we can calculate the lattice constants $a = 0.398$ nm, $b = 1.452$ nm and $c = 1.372$ nm, consistent with the result of TEM. The EDX spectrum detected Zr, Te, C and Cu, which were attributed to the NWs, the carbon film and copper grid (Fig. 2d). The Zr/Te atomic ratio in the EDX area was 0.28, which was much lower than that of the nominal composition. This discrepancy is probably due to the vacancies of Te atoms, similar to those reported in 3D TI, Bi₂Te₃¹². The band dispersion obtained by ARPES measurement of bulk ZrTe₅ crystal⁸ at 80 K is sketched in the inset of Fig. 2d. An almost linear E-K dispersion (as indicated by the yellow dashed lines) was observed near the Γ point, suggesting the presence of Dirac fermions. Moreover, the energy dispersion shows a small gap opening rather than massless Dirac cone. Note that our ARPES result was done at 80 K, and the band diagram is going to shift down as the temperature decreases to lower values of 2–20 K¹³, which results in the E_F of our samples (S1 and S2) shifting up as indicated by the green lines at lower temperatures similar to that from the ref.², as estimated from the quantum oscillations. The temperature dependent shift of E_F is probably due to the change of lattice constants^{1,14}, as the temperature decreases.

Electrical transport measurements of ZrTe₅ NW devices. Figure 3a exhibits a four-probe device with Au contacts while the width and channel length are 3.2 μm and 4.6 μm , respectively. The temperature dependent longitudinal resistance R_{xx} of S2 is shown in Fig. 3b. R_{xx} demonstrates a peak at 125 K, known as the “resistivity anomaly”, close to the values reported in previous work (~60–170 K). This resistivity anomaly might be associated with a change in the electronic structure caused by thermal expansion, and the detailed physics is still under debating^{2–4,15–30}.

As we know, one of the persuasive proofs for characterizing nontrivial conducting states is regarded as SdH oscillations^{8,29–32}. According to this, low-temperature magneto transport measurements were carried out to demonstrate the nontrivial conducting states in ZrTe₅ NWs experimentally.

The angle dependent magneto transport properties of S1 are shown in Fig. 3c,d. Figure 3c exhibits the field dependent resistance for different θ (0°, 30°, 45°, 60° and 90°) from -9 T to $+9$ T at 2 K before subtracting the smooth background. Here θ is the tilt angle between the field direction \mathbf{B} and the crystallographic b-axis, within b-a plane. The magnetoresistance, MR curves display pronounced SdH oscillations from 0° to 60°. While $\text{MR}(B) = (R(B) - R(0))/R(0)$, typically has a magnitude of 321% near 9 T, the amplitude of the SdH signal is small and amounts to only 0.4% of the total resistance. After subtracting a smooth background, ΔR_{xx} demonstrates much more clear oscillations. The inset of Fig. 3c shows the magnetic field B corresponding to the $n = 3$ minimum at varies rotation angles θ , up to 60°. It follows $1/\cos(\theta)$ perfectly. This concludes that the quantum oscillations arise from a 2D Fermi surface.

Quantum oscillations arising from the 2D nontrivial states. The temperature dependent magneto transport properties of S2 after subtracting a smooth background is shown in Fig. 4a. The oscillatory part of R_{xx} (ΔR_{xx}) reveals periodic dependences with peaks (maxima) and valleys (minima) versus $1/B$, indicating there’s a well-defined Fermi surface^{31,33,34}. The magnetic field is perpendicular to both the c-axis and the charge current flow (a-axis) of the ZrTe₅ NW ($\theta = 0^\circ$). The SdH oscillations can be seen from 2 K up to 20 K. After fast Fourier transform (FFT) we can obtain a single oscillation frequency ($f_{\text{SdH}}(T)$, 3.57 T). For a 2D system, the Onsager

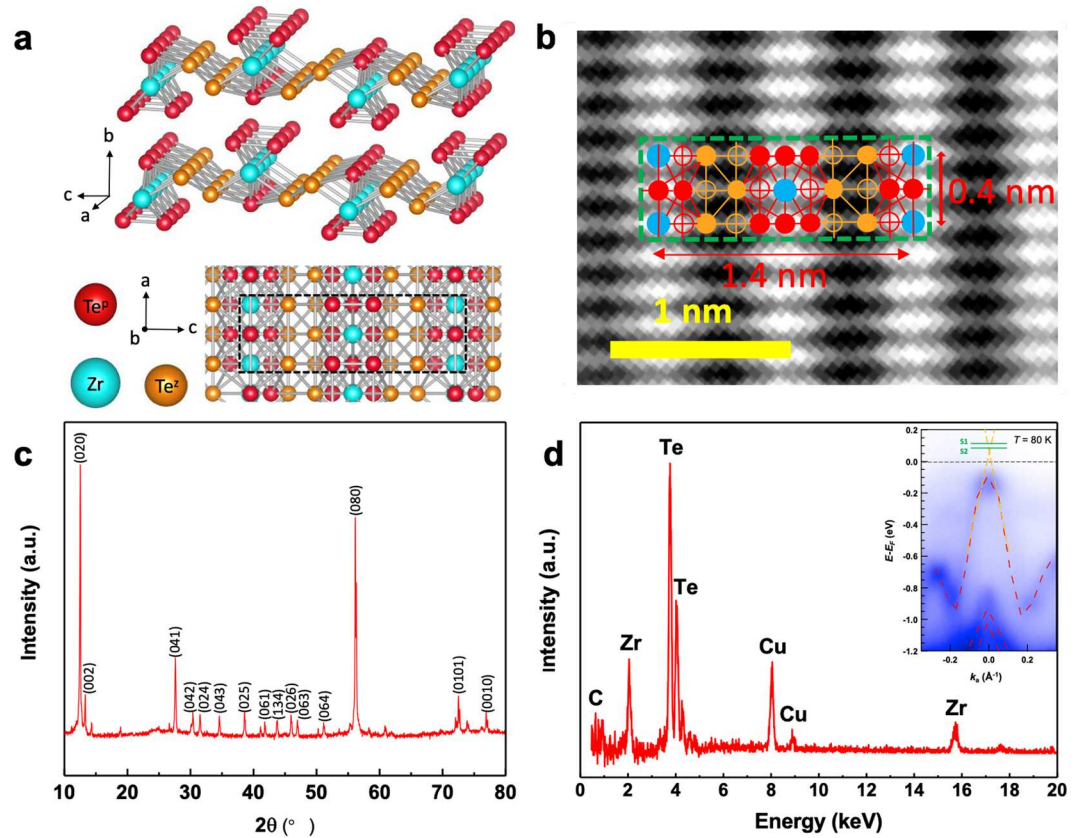


Figure 2. Structural characterization of ZrTe_5 crystal. (a) Top: Tilt view of the crystal structure of ZrTe_5 layers. The blue spheres represent Zr atoms and the red and orange spheres represent the prismatic (Te^p) and the zigzag Te (Te^z) atoms, respectively. Bottom: Top view of the crystal structure of two ZrTe_5 layers. Atoms at the top layer are brighter, and that at the bottom layer are dimmer. The black dashed rectangular marks one unit cell. (b) TEM image of a ZrTe_5 NW on a holey carbon grid reveals a perfect crystalline structure. The unit cell is shown in dashed green rectangular. The solid and open symbols represent atoms in the top and the second layers. Blue, red and orange circles represent Zr, Te^p and Te^z , respectively. The bright spots are due to the overlapping of Zr and Te atoms in the projection. The measured lattice constants are $a = 0.4$ nm and $c = 1.4$ nm. (c) X-ray powder diffraction pattern of ZrTe_5 NWs. All the peaks can be indexed by ZrTe_5 crystal, and the calculated lattice constants are $a = 0.398$ nm, $b = 1.452$ nm, and $c = 1.372$ nm. (d) EDX spectrum of ZrTe_5 NWs, Zr and Te are the only elements that can be detected, except C and Cu. The inset shows the ARPES image of bulk ZrTe_5 crystal at 80 K. For comparison, the calculated band structure is plotted on top of the experimental data (red dashed curves). The green lines represent the E_F of S1 and S2 obtained below, respectively.

formula: $f_{\text{SdH}} = (h/4\pi^2e)S_F$, can describe the relation between SdH oscillation frequency and the cross section of the Fermi surface (S_F), where $S_F = \pi k_F^2$, k_F is the Fermi vector, e is the electron charge, and h is Planck constant. The 2D surface carrier density (n_{2D}) can be calculated by $n_{2D} = k_F^2/4\pi$. Then we can extract k_F to be 0.0104 \AA^{-1} by substituting S_F in f_{SdH} , corresponding to $n_{2D} = 0.86 \times 10^{11} \text{ cm}^{-2}$.

The $1/B$ values of the maxima (hollow rectangles) and the minima (hollow circles) in ΔR_{xx} versus Landau level index n^{35} are plotted in Fig. 4b. We extracted a finite intercept of 0.580 ± 0.001 , by linear fitting of the data, indicating a Berry phase of $\sim \pi$, emphasizing the topological nature of the SdH oscillations. We have noticed that there's a little discrepancy between the intercept and $1/2$. The reason could be that for 3D or quasi-2D crystal, there is an additional phase shift determined by the dimensionality of the Fermi surface and the value changes from 0 for surface states (2D) to $\pm 1/8$ for bulk states (3D)³⁶. Such inconsistency may also be attributed to the Zeeman splitting and/or the multiple Hall-channel contributions³⁷.

The temperature-dependent amplitude of $\Delta\sigma_{xx}$ can be written as $\Delta\sigma_{xx}(T)/\Delta\sigma_{xx}(0) = \lambda(T)/\sinh(\lambda(T))$, where $\lambda(T) = 2\pi^2 k_B T m_{\text{cycl}} / (\hbar e B)$, m_{cycl} is the cyclotron mass, \hbar is the reduced Planck's constant, and k_B is Boltzmann's constant. After fitting the conductivity oscillation amplitude to the $\Delta\sigma_{xx}(T)/\Delta\sigma_{xx}(0)$ equation, m_{cycl} is calculated to be $\sim 0.031 m_e$ (m_e is the free electron mass), which is shown in Fig. 4c. For a Dirac-like dispersion, $E_F = \hbar k_F V_F = p_F V_F$ and also $p_F = m_{\text{cycl}} V_F$ so $m_{\text{cycl}} = E_F / V_F^{2,29,32,38}$. This yields a Fermi level of ~ 26.64 meV above the Dirac point and a Fermi velocity of $\sim 3.89 \times 10^5$ m/s, which is in a good agreement with results reported by others^{5,39}.

We can extract the transport lifetime of the surface states (τ) by the Dingle plot^{30,31,33,40}. Since $\Delta R/R_0 \sim [\lambda(T)/\sinh\lambda(T)]e^{-D}$, where $D = 2\pi^2 E_F / \tau e B V_F^2$, the lifetime τ can be obtained by the slope in Dingle plot by

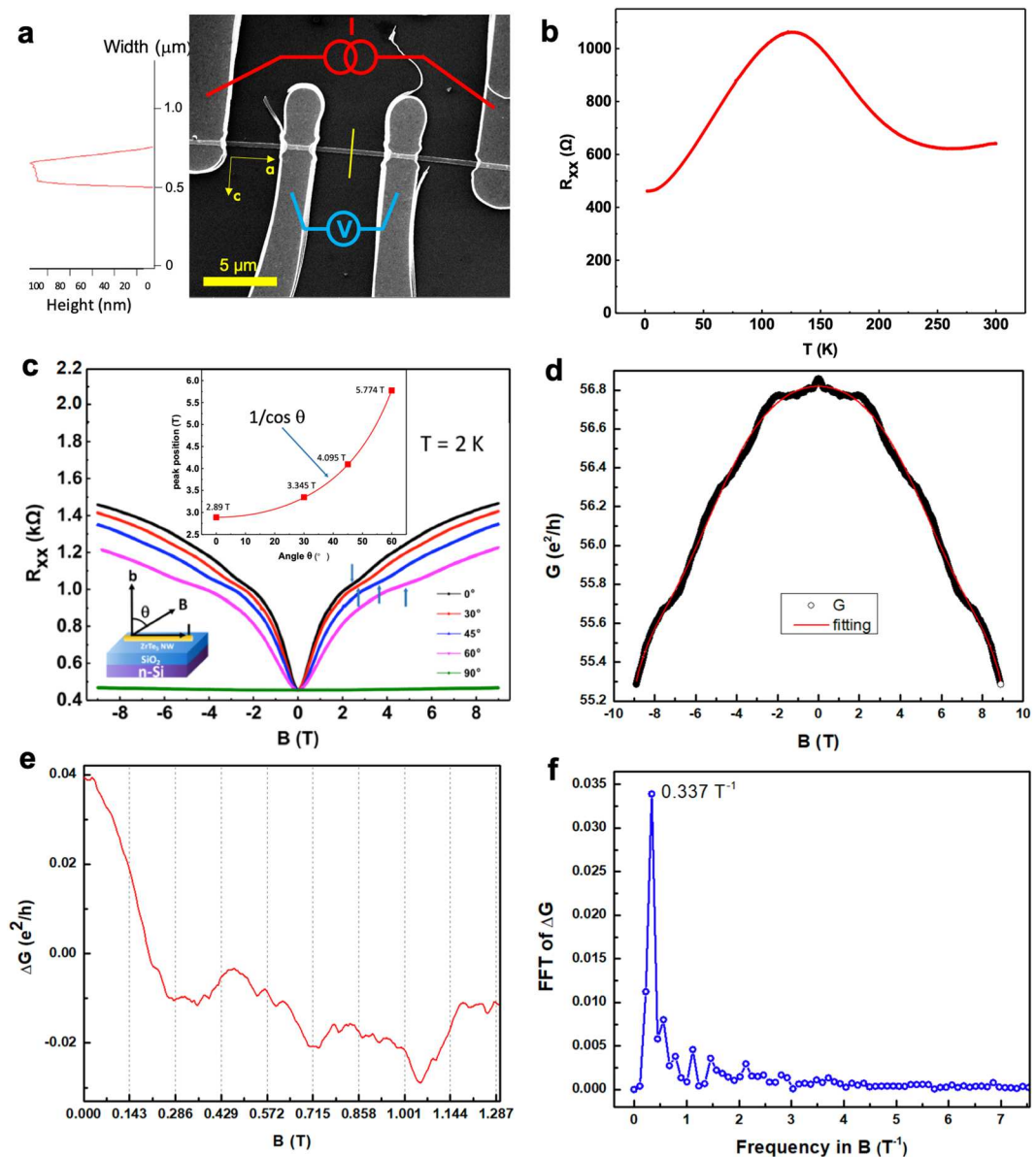


Figure 3. Electrical transport measurements of ZrTe₅ NW devices. (a) An SEM image of the ZrTe₅ NW device with four Au contacts. The channel length is 4.6 μm. The thickness of the NW is ~100 nm, measured by AFM (a line cut in the inset, indicated with the yellow short line in the SEM image). The crystallographic a- and c-axis are shown by two arrows, respectively. (b) Temperature dependent longitudinal resistance. A resistance peak at ~125 K can be observed. (c) The field dependent resistance at different tilt angle θ . Oscillations can be seen from the raw data. The inset shows the field position of the $n = 3$ LL valley for sample S1 (blue arrows in c) varies with θ as $1/\cos\theta$ (red curve), consistent with a 2D FS. (d) Zoom-in image of the magneto-conductance in the unit of e^2/h at $\theta = 90^\circ$ (black dots) and the background of a polynomial fit (red solid line). (e) The magneto-conductance after subtracted the smooth polynomial, shows no A-B oscillations with a period of 0.143 T. (f) FFT of the ΔG curve with a peak at 0.337 T^{-1} marked on the image.

$\log[(\Delta R/R_0)B \sinh(\lambda(T))] \approx [2\pi^2 E_F / (\tau e V_F^2)] \times (1/B)$. The fit in Fig. 4d extracts a lifetime $\tau \sim 1.5 \times 10^{-12}$ s, indicating a mean free path l of ~583 nm ($l = V_F \tau$). The surface mobility $\mu_s = e\tau/m_{\text{cycl}} = el/hk_F$ can be estimated as ~85000 $\text{cm}^2 \text{V}^{-1} \text{s}^{-1}$ (see Table 1). Note that the high mobility in our ZrTe₅ NW with a Zr/Te atomic ratio of 0.28 is reasonable since the 2D conducting states' mobilities of topological materials are always very high. And for our samples, although the bulk have a lot of Te vacancies, the 2D conducting states are robust again those non-magnetic defects³. According to these results, the 2D nontrivial conducting states contribution to the total conduction can be calculated as ~8.68% (Table 2).

The absence of A-B oscillations. Quantum interference effects, such as A-B oscillations⁴¹ associated with the surface states may occur for mesoscopic samples where the low-temperature mean free path is comparable to the sample dimensions. Theoretically, only half revolution around the perimeter of the NW (~390 nm, since

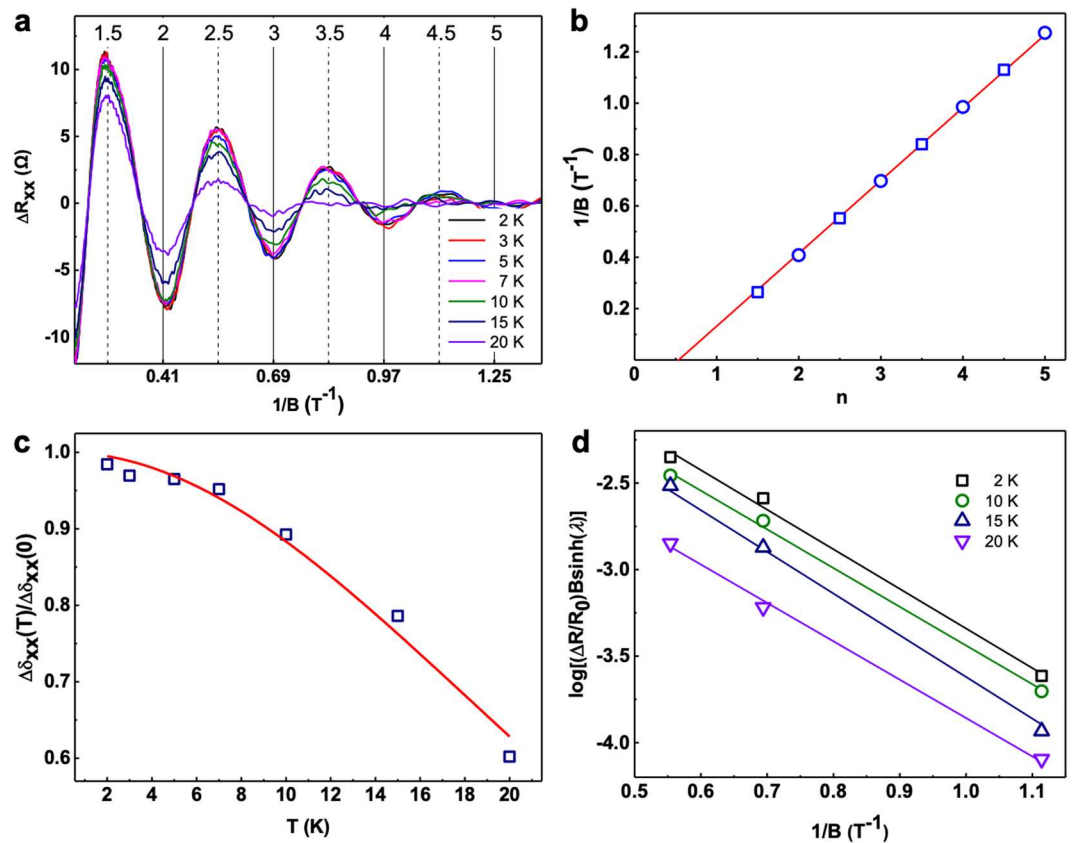


Figure 4. Quantum oscillations arising from the 2D nontrivial states. (a) Temperature dependent SdH oscillations of ZrTe₅ NWs at $\theta = 0^\circ$. The black solid lines mark the SdH valleys at Landau filling factors of 2, 3, 4 and 5, while the dash lines mark the peaks at 1.5, 2.5, 3.5 and 4.5. (b) Landau-level fan diagram. Linear fitting gives a nonzero intercept of 0.580, corresponding to a Berry phase of $\sim \pi$. (c) Temperature dependence of the normalized conductivity amplitude $\Delta\sigma_{xx}(T)/\Delta\sigma_{xx}(0)$. The solid red line is the best fit to $\lambda(T)/\sinh(\lambda(T))$. A magnetic field of 5.22 T was used to extract the cyclotron effective mass: $\sim 0.031 m_e$. (d) Dingle plots of $\log[(\Delta R/R_0)B\sinh(\lambda)]$ versus $1/B$ at four different temperatures. Transport lifetime τ , mean free path $l = V_F\tau$, and mobility μ can be extracted from the best fit to $\log[(\Delta R/R_0)B\sinh(\lambda)]$.

Sample	f_{SdH} (T)	$n_{2\text{D}}$ (10^{11} cm^{-2})	m_{cycl} (m_e)	k_F (\AA^{-1})	V_F (10^5 ms^{-1})	E_F (meV)	τ (10^{-12} s)	l (nm)	μ ($\text{cm}^2 \text{ V}^{-1} \text{ s}^{-1}$)
S1	8.58	2.08	0.037	0.0161	5.04	53.59	1.75	881	82915
S2	3.57	0.86	0.031	0.0104	3.89	26.64	1.5	583	85083

Table 1. Estimated parameters from the SdH oscillations at $T = 2 \text{ K}$.

Sample	$G(\text{SdH})$ (mS)	$R(\text{total})$ (Ω)	$R_{\text{sheet}}(\text{total})$ ($\Omega \gamma^{-1}$)	$G_{\text{sheet}}(\text{total})$ (mS)	$G(\text{SdH})/G_{\text{sheet}}(\text{total})$
S1	2.76	453.7	9.07	11.02	$\sim 2.50\%$
S2	1.18	460.9	73.74	13.56	$\sim 8.68\%$

Table 2. Estimated surface conduction percentage with zero magnetic field and at $T = 2 \text{ K}$.

the thickness (t) and width (w) of our NW are 100 nm and 290 nm respectively) is required for the interference effect of the A-B oscillations. Practically the mean free path l extracted from our results is $\sim 583 \text{ nm}$, which is a lower estimation of the phase-coherent diffusion length in general. So, the phase-coherent diffusion length is long enough for the observation of A-B oscillations in the NW, if it exists.

Further calculation indicates that the cross-sectional area of the NW is $S = w \times t = 2.9 \times 10^{-14} \text{ m}^2$. Thus, the characteristic period of the A-B oscillations should be $\Delta B = \Phi_0/S = 0.143 \text{ T}$, where $\Phi_0 = h/e$ is the flux quantum, S is the cross-sectional area of the NW, h is Planck's constant and e is the electron charge³². Meanwhile, we can estimate the amplitude of the A-B oscillations, if exist. The unsuppressed amplitude of A-B oscillations should be in the order of e^2/h in conductance, which means when $G_0 (= 1/R_0)$ changes in e^2/h , the resistance after changing

should be $1/(1/R_0 + e^2/h)$, giving the $\Delta R = R_0 - R$. That is, $\Delta R = \Delta(1/G) \approx R_0 - 1/(1/R_0 + e^2/h) \approx 7.85 \Omega$, considering $R_0 \sim 454.1 \Omega$. However, for the magneto-conductance curves in the unit of e^2/h at $\theta = 90^\circ$ ($B//I$), there's no A-B oscillations in our NWs (Fig. 3d).

After subtracted the smooth background (red lines in Fig. 3d), the magneto-conductance trace ΔG measured in a longitudinal field is shown in Fig. 3e. From this quantum magneto-conductance curve, there's no such oscillations consistent with the calculated A-B oscillations whose period should be 0.143 T. Meanwhile, the upper bound of ΔG is $\sim 0.04 e^2/h$.

However, A-B oscillations are usually suppressed in cylindrical conductors, like our NWs. The main origins of this reduction are probably as follows. First, different slices of the metal cylinder (effectively 2D metal ring) generate A-B oscillations of random phases, canceling each other. Second, the electrons circle along the NW perimeter in a quasi-ballistic manner, but drift along the longitudinal direction of the NW in a diffusive manner (mean free path $<$ the length of NW, L_{NW}). As probing the longitudinal conductance, A-B oscillation amplitude of conductance may be reduced due to the diffusive transport in longitudinal direction⁴¹.

While, in 2014, Seung Sae Hong *et al.* from Prof. Yi Cui's group have studied the effect of NW length on the A-B oscillations. Generally, L_{NW} is comparable or longer than phase coherence length (L_ϕ). Especially at high temperature, L_{NM} is expected to be much longer than L_ϕ . Therefore, if A-B oscillations are of random phase nature, oscillations of different segments ($L_{NM} \sim L_\phi(T)$) would be averaged out by additional factor $(L_{NM}/L_\phi(T))^{-1/2}$ ⁴². Then the amplitude of A-B oscillations in our experiments should be around $7.85 \Omega * (4.62 \mu\text{m}/583 \text{ nm})^{-1/2} \approx 2.79 \Omega$ near 454.1Ω because of the suppression, corresponding to $0.3491 e^2/h$, which is still much larger than our upper bound ($\sim 0.04 e^2/h$). Thus, to our detecting limit of $10^{-3} e^2/h$, there is no A-B oscillations.

The fast Fourier transform after background subtraction is also shown in Fig. 3f, which only has one pronounced peak at 0.337 T^{-1} . This number is not close to the A-B oscillation frequency of 6.993 T^{-1} ($\sim 1/0.143 \text{ T}$) estimated from the cross-section area, which again confirms the absence of A-B oscillations. After carefully analyzing our data, we believe this oscillation could originate from the systematical errors of our system, probably because of the digital noises in our measurement system or from the universal conductance fluctuations⁴³. If we changed the scanning speed or data acquisition speed, the background oscillation frequencies scale with it.

The absence of the A-B oscillations may be attributed to no conducting channels at the sidewalls, because of the weak interlayer coupling, as shown in Fig. 1c. Thus, there is no path for the Dirac electrons to travel around the perimeter of the NW. Therefore, we have provided another piece of evidence that ZrTe₅ NW is a quasi-2D Dirac semimetal with very weak interlayer coupling, which is in a good agreement with W. Wang *et al.*'s conclusion¹⁰.

Discussion

In summary, we have fabricated the ZrTe₅ NWs devices with four-terminal geometry and measured the magnetoresistance properties under varied temperatures and angles. The angle-dependent SdH oscillations have unambiguously shown nontrivial conducting states with high carrier mobility ($\sim 85000 \text{ cm}^2\text{V}^{-1}\text{s}^{-1}$), and they contribute up to 8.68% of the total conductance. Since the metallic properties under very low temperatures of our NWs and the non-zero Berry phase we obtained, we believe our ZrTe₅ NWs belong to the Dirac semimetal. In addition, the negative magnetoresistance properties observed by Qiang Li *et al.*⁵ confirm again that ZrTe₅ should be a Dirac semimetal. The absence of A-B oscillations suggests that there's no path for the electrons to travel around the perimeter of our NWs. This together with the SdH oscillations suggest that there is only weak interlayer coupling between adjacent layers of the ZrTe₅ NWs.

Methods

The ZrTe₅ crystal was grown by chemical vapor transportation (CVT) method. ZrTe₅ was firstly exfoliated on scotch tape and then transferred onto 300 nm/300 μm SiO₂/p-Si substrate. Conventional photolithography was used to pattern the ZrTe₅ NWs into a micron-scale four-terminal device followed by a subsequent dry etching (5–15 s Ar ion etching). Four paralleled electrodes (50 nm Au) were defined by e-beam evaporation and the lift-off process. To study the 2D nontrivial conducting states of our ZrTe₅ NWs, magneto transport measurements were conducted. A schematic diagram of the device structure is shown in Fig. 3a. The current is along the a-axis as shown by the yellow arrows. In order to study the angle-dependent and the temperature-dependent magneto transport properties, we have fabricated two devices with same geometry called S1 and S2, respectively.

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Author Contributions

Pei Yang fabricated the devices, prepared Fig. 1a,b, Fig. 2c,d, Fig. 3 and Fig. 4 and wrote the main manuscript text with the help from Wei Wang and Liang He. Wei Wang synthesized the ZrTe₅ NWs, carried out low-temperature transport measurements and XRD pattern. Xiaoqian Zhang helped with the low-temperature transport measurements and carried out the TEM measurement. Kejie Wang prepared Fig. 1c and Fig. 2a. Liang He contributed to the analysis and paper revise. Wenqing Liu also revised the manuscript. Yongbing Xu reviewed the manuscript, too. Pei Yang and Wei Wang contributed equally to this work.

Additional Information

Competing Interests: The authors declare no competing interests.

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